## Application/Control No. Applicant(s)/Patent Under Reexamination 10/051,545 LU, YANFENG Notice of References Cited Examiner Art Unit Page 1 of 1 Wen-Tai Lin 2154 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY \* US-6,623,529 09-2003 Lakritz, David 715/536 US-6,964,014 11-2005 715/513 В Parish, Sandy US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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